

Day : Friday Date: 6/27/2008

Time: 14:48:20

Inventor Name Search Result

Your Search was:

Last Name = MARX First Name = ECKHARD

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Application#	Patent#	Status	Date Filed	Title	Inventor Name
09128386	Not Issued	161	08/03/1998	METHOD OF IDENTIFYING WAFERS	MARX, ECKHARD
09128387	6147321	150	08/03/1998	CONFIGURATION FOR THE AUTOMATIC INSCRIPTION OR REINSCRIPTION OF WAFERS	MARX, ECKHARD
09431575	Not Issued	161	11/01/1999	METHOD AND APPARATUS FOR THE OPTICAL SURFACE ANALYSIS OF SEMICONDUCTOR WAFERS	MARX, ECKHARD
09495795	6261382	150	02/01/2000	Wafer marking	MARX, ECKHARD
09923701	Not Issued	161	08/06/2001	Apparatus and method for removing an organic material from a semiconductor device	MARX, ECKHARD
10016633	6914006	150	10/30/2001	WAFER SCRIBING METHOD AND WAFER SCRIBING DEVICE	MARX, ECKHARD
10090259	6745637	150	03/04/2002	SELF-SUPPORTING ADAPTABLE METROLOGY DEVICE	MARX, ECKHARD
10638599	6935201	150	08/11/2003	MEASUREMENT CONFIGURATION INCLUDING A VEHICLE AND METHOD FOR PERFORMING MEASUREMENTS WITH THE MEASUREMENT CONFIGURATION AT VARIOUS LOCATIONS	MARX, ECKHARD
10715073	Not Issued	71	11/17/2003	Configuration and method for detecting defects on a substrate in a processing tool	MARX, ECKHARD
10816142	6866200	150	04/02/2004	SEMICONDUCTOR DEVICE	MARX, ECKHARD

			IDENTIFICATION APPARATUS	
10877262	7262837	150	NONINVASIVE METHOD FOR CHARACTERIZING AND IDENTIFYING EMBEDDED MICROPATTERNS	MARX, ECKHARD

## Inventor Search Completed: No Records to Display.

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